

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/507,388	<b>Applicant(s)/Patent under Reexamination</b> SHIN ET AL.
	<b>Examiner</b> Tod T. Van Roy <i>[Signature]</i>	<b>Art Unit</b> 2828

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner